

MC10131

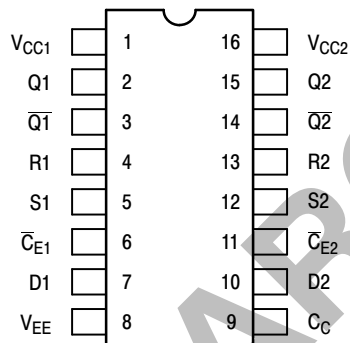
Dual Type D Master-Slave Flip-Flop

The MC10131 is a dual master-slave type D flip-flop. Asynchronous Set (S) and Reset (R) override Clock (C_C) and Clock Enable (C_E) inputs. Each flip-flop may be clocked separately by holding the common clock in the low state and using the enable inputs for the clocking function. If the common clock is to be used to clock the flip-flop, the Clock Enable inputs must be in the low state. In this case, the enable inputs perform the function of controlling the common clock.

The output states of the flip-flop change on the positive transition of the clock. A change in the information present at the data (D) input will not affect the output information at any other time due to master slave construction.

- $P_D = 235 \text{ mW typ/pkg (No Load)}$
- $F_{Tog} = 160 \text{ MHz typ}$
- $t_{pd} = 3.0 \text{ ns typ}$
- $t_r, t_f = 2.5 \text{ ns typ (20\%–80\%)}$

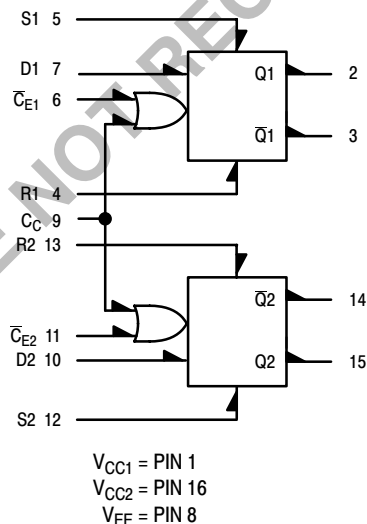
DIP PIN ASSIGNMENT



Pin assignment is for Dual-in-Line Package.

For PLCC pin assignment, see the Pin Conversion Tables on page 18 of the ON Semiconductor MECL Data Book (DL122/D).

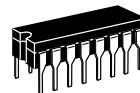
LOGIC DIAGRAM



ON Semiconductor

<http://onsemi.com>

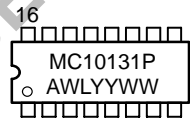
MARKING DIAGRAMS



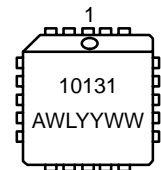
CDIP-16
L SUFFIX
CASE 620



PDIP-16
P SUFFIX
CASE 648



PLCC-20
FN SUFFIX
CASE 775



A = Assembly Location
 WL = Wafer Lot
 YY = Year
 WW = Work Week

CLOCKED TRUTH TABLE

C	D	Q_{n+1}
L	X	Q_n
H	L	L
H	H	H

$C = C_E + C_C$. A clock H is a clock transition from a low to a high state.

R-S TRUTH TABLE

R	S	Q_{n+1}
L	L	Q_n
L	H	H
H	L	L
H	H	N.D.

N.D. = Not Defined

ORDERING INFORMATION

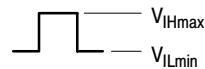
Device	Package	Shipping
MC10131L	CDIP-16	25 Units / Rail
MC10131P	PDIP-16	25 Units / Rail
MC10131FN	PLCC-20	46 Units / Rail

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Pin Under Test	Test Limits							Unit
			−30°C		+25°C			+85°C		
			Min	Max	Min	Typ	Max	Min	Max	
Power Supply Drain Current	I _E	8		62		45	56		62	mAdc
Input Current	I _{inH}	4		525			330		330	μAdc
		5		525			330		330	
		6		350			220		220	
		7		390			245		245	
		9		425			265		265	
	I _{inL}	4, 5* 6, 7, 9*	0.5 0.5		0.5 0.5			0.3 0.3		μAdc
Output Voltage Logic 1	V _{OH}	2 2†	−1.060 −1.060	−0.890 −0.890	−0.960 −0.960		−0.810 −0.810	−0.890 −0.890	−0.700 −0.700	Vdc
Output Voltage Logic 0	V _{OL}	2 3†	−1.890 −1.890	−1.675 −1.675	−1.850 −1.850		−1.650 −1.650	−1.825 −1.825	−1.615 −1.615	Vdc
Threshold Voltage Logic 1	V _{OHA}	2 2†	−1.080 −1.080		−0.980 −0.980			−0.910 −0.910		Vdc
Threshold Voltage Logic 0	V _{OLA}	2 3†		−1.655 −1.655			−1.630 −1.630		−1.595 −1.595	Vdc
Switching Times (50Ω Load) Clock Input										ns
Propagation Delay	t _{g+2−}	2	1.7	4.6	1.8	3.0	4.5	1.8	5.0	
	t _{g+2+}	2	1.7	4.6	1.8	3.0	4.5	1.8	5.0	
	t ₆₊₂₊	2	1.7	4.6	1.8	3.0	4.5	1.8	5.0	
	t _{6+2−}	2	1.7	4.6	1.8	3.0	4.5	1.8	5.0	
Rise Time (20 to 80%)	t ₂₊	2	1.0	4.6	1.1	2.5	4.5	1.1	4.9	
Fall Time (20 to 80%)	t _{2−}	2	1.0	4.6	1.1	2.5	4.5	1.1	4.9	
Set Input										ns
Propagation Delay	t ₅₊₂₊	2	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
	t ₁₂₊₁₅₊	15	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
	t _{5+3−}	3	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
	t _{12+14−}	14	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
Reset Input										ns
Propagation Delay	t _{4+2−}	2	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
	t _{13+15−}	15	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
	t _{4+3−}	3	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
	t ₁₃₊₁₄₊	14	1.7	4.4	1.8	2.8	4.3	1.8	4.8	
Setup Time	t _{setup}	7	2.5		2.5			2.5		ns
Hold Time	t _{hold}	7	1.5		1.5			1.5		ns
Toggle Frequency (Max)	f _{tog}	2	125		125	160		125		MHz

* Individually test each input applying V_{IH} or V_{IL} to input under test.

† Output level to be measured after a clock pulse has been applied to the $\overline{C_E}$ Input (Pin 6)

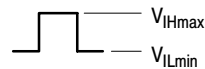


ELECTRICAL CHARACTERISTICS (continued)

@ Test Temperature			TEST VOLTAGE VALUES (Volts)					(V _{CC}) Gnd
			V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{EE}	
			−0.890	−1.890	−1.205	−1.500	−5.2	
			−0.810	−1.850	−1.105	−1.475	−5.2	
			−0.700	−1.825	−1.035	−1.440	−5.2	
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW					(V _{CC}) Gnd
			V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{EE}	
Power Supply Drain Current	I _E	8					8	1, 16
Input Current	I _{inH}	4	4				8	1, 16
		5	5				8	1, 16
		6	6				8	1, 16
		7	7				8	1, 16
		9	9				8	1, 16
	I _{inL}	4, 5* 6, 7, 9*		*			8 8	1, 16 1, 16
Output Voltage Logic 1	V _{OH}	2	5				8	1, 16
		2†	7				8	1, 16
Output Voltage Logic 0	V _{OL}	2	5				8	1, 16
		3†	7				8	1, 16
Threshold Voltage Logic 1	V _{OHA}	2			5		8	1, 16
		2†			7	9	8	1, 16
Threshold Voltage Logic 0	V _{OLA}	2			5		8	1, 16
		3†			7	9	8	1, 16
Switching Times (50Ω Load) Clock Input			+1.11Vdc		Pulse In	Pulse Out	−3.2 V	+2.0 V
Propagation Delay	t _{g+2−} t _{g+2+} t ₆₊₂₊ t _{6+2−}	2			9	2	8	1, 16
		2	7		9	2	8	1, 16
		2	7		6	2	8	1, 16
		2			6	2	8	1, 16
		2			6	2	8	1, 16
Rise Time (20 to 80%)	t ₂₊	2	7		9	2	8	1, 16
Fall Time (20 to 80%)	t _{2−}	2			9	2	8	1, 16
Set Input	Propagation Delay	t ₅₊₂₊			5	2	8	1, 16
		t ₁₂₊₁₅₊	15	6	12	15	8	1, 16
		t _{5+3−}	3		5	3	8	1, 16
		t _{12+14−}	14	9	12	14	8	1, 16
Reset Input	Propagation Delay	t _{4+2−}			4	2	8	1, 16
		t _{13+15−}	15	6	13	15	8	1, 16
		t _{4+3−}	3		4	3	8	1, 16
		t ₁₃₊₁₄₊	14	9	13	14	8	1, 16
Setup Time	t _{setup}	7			6, 7	2	8	1, 16
Hold Time	t _{hold}	7			6, 7	2	8	1, 16
Toggle Frequency (Max)	f _{tog}	2			6	2	8	1, 16

* Individually test each input applying V_{IH} or V_{IL} to input under test.

† Output level to be measured after a clock pulse has been applied to the \overline{C}_E Input (Pin 6)

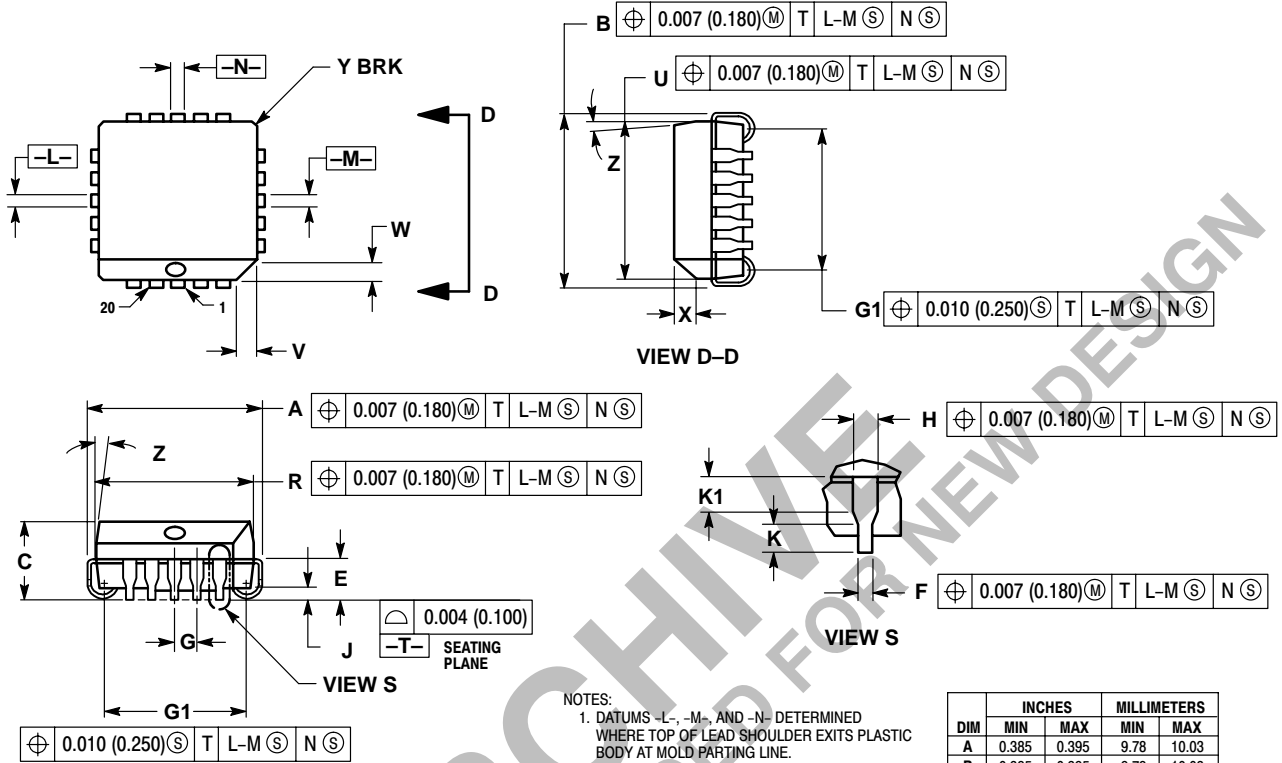


Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to −2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

MC10131

PACKAGE DIMENSIONS

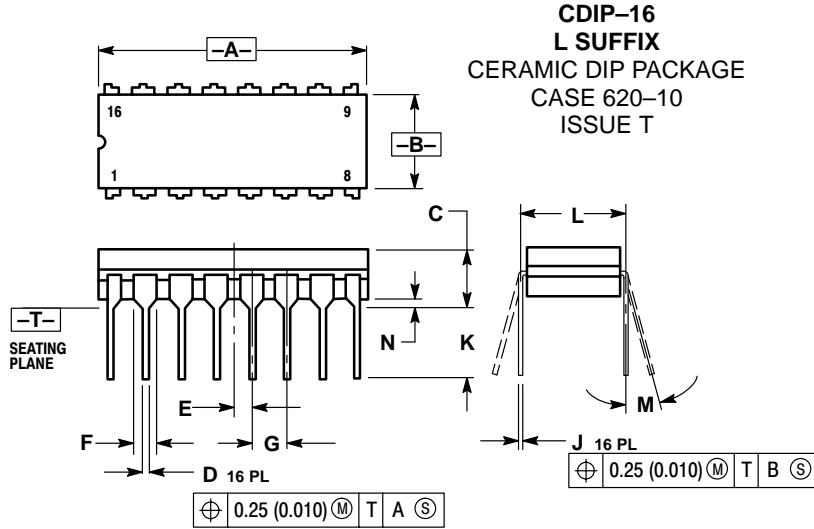
PLCC-20
FN SUFFIX
PLASTIC PLCC PACKAGE
CASE 775-02
ISSUE C



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.385	0.395	9.78	10.03
B	0.385	0.395	9.78	10.03
C	0.165	0.180	4.20	4.57
E	0.090	0.110	2.29	2.79
F	0.013	0.019	0.33	0.48
G	0.050 BSC		1.27 BSC	
H	0.026	0.032	0.66	0.81
J	0.020	---	0.51	---
K	0.025	---	0.64	---
R	0.350	0.356	8.89	9.04
U	0.350	0.356	8.89	9.04
V	0.042	0.048	1.07	1.21
W	0.042	0.048	1.07	1.21
X	0.042	0.056	1.07	1.42
Y	---	0.020	---	0.50
Z	2 °	10 °	2 °	10 °
G1	0.310	0.330	7.88	8.38
K1	0.040	---	1.02	---

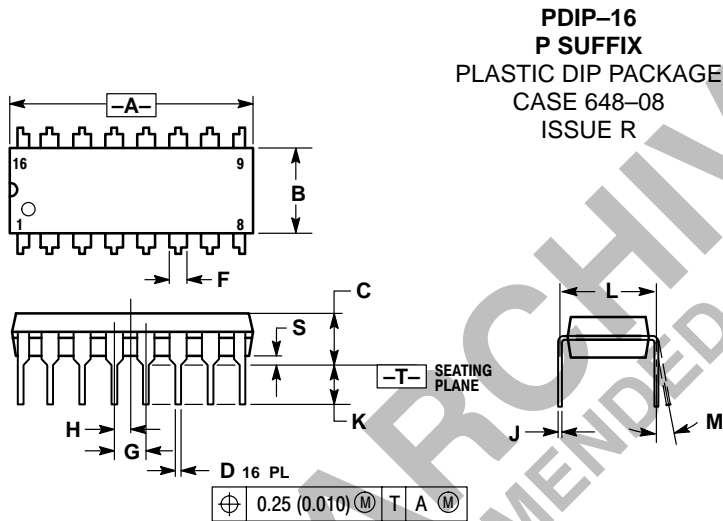
MC10131

PACKAGE DIMENSIONS



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
 4. DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.750	0.785	19.05	19.93
B	0.240	0.295	6.10	7.49
C	---	0.200	---	5.08
D	0.015	0.020	0.39	0.50
E	0.050 BSC		1.27 BSC	
F	0.055	0.065	1.40	1.65
G	0.100 BSC		2.54 BSC	
H	0.008	0.015	0.21	0.38
K	0.125	0.170	3.18	4.31
L	0.300 BSC		7.62 BSC	
M	0°	15°	0°	15°
N	0.020	0.040	0.51	1.01



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
 5. ROUNDED CORNERS OPTIONAL.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.740	0.770	18.80	19.55
B	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100 BSC		2.54 BSC	
H	0.050 BSC		1.27 BSC	
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0°	10°	0°	10°
S	0.020	0.040	0.51	1.01


Notes

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Notes

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